

CALIFORNIA INSTITUTE OF TECHNOLOGY MASSACHUSETTS INSTITUTE OF TECHNOLOGY

# E010064-A-D DOC NO. - REV. - GID DATE: 3/27/00

ONENT SPECIFICATION

Sheet 1 of 2

### TITLE Substrates for Coating Effect on Mechanical Quality Factor R&D

APPROVALS:	DATE	APPROVALS:		DATE
DRAWN: Jordan Camp	3/27/01	CHECKED:		
CHECKED: Dennis Coyne	3/27/01	CHECKED:		
CHECKED:		DCN NO	APPROVED	DATE
CHECKED:		E010065-00-D	Dennis Coyne	3/27/01

#### Scope

The substrates defined by this specification are to be used in research to establish the effect of high performance dielectric coatings on the mechanical quality factor (Q) of fused silica. These fused silica substrates have high intrinsic Q which should not be compromised significantly by material impurities, inhomogeneities, defects or processing steps which deviate radically from the processes used in full scale optics manufacturing.

#### Applicable Documents

LIGO-D010067-A-D	Mechanical Q R&D Substrate, Type A
LIGO-D010068-A-D	Mechanical Q R&D Substrate, Type B
Requirements:	
Physical Dimensions	per LIGO-D010067-A Mechanical Q R&D Blank, Type A per LIGO-D010068-A Mechanical Q R&D Blank, Type B (essentially 3.0 inch diameter and 1.0 inch thick for type A, 0.1 inch thick for type B)
Serial Number / Marking	None
Material	Fused Silica, Corning 7980, Grade 0-A

#### Side and Chamfer Polish

Sides and Chamfers shall appear transparent with no grey, scuffs or scratches visible to the naked eye when viewed in normal room light against a black background.

#### Scratches and Dig defects

An 80/50 or better scratch/dig finish on both sides.

#### Surface Figure & Low Spatial Frequency Error, measured over the central 60 mm diameter

All specified quantities refer to the physical surface of the optic.

The following root mean square standard deviation ( $\sigma_{rms}$ ) values are calculated from the phase maps which are to be provided with each optic.  $\sigma_{rms}$  is defined as the square root of the mean of the square of each pixel value. Known bad pixels are excluded from this calculation.

Surface 1: Nominally flat. Maximum rms surface figure error,  $\sigma_{rms} < \lambda/10$  (where  $\lambda = 633$  nm) for Type A  $<\lambda/2$ for Type B

Surface 2: Nominally flat.



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# **COMPONENT SPECIFICATION**

CONTINUATION SHEET

# **Substrates for Coating Effect on Mechanical Quality Factor R&D**

#### **High Spatial Frequency Band** Measured at two locations:

Surface 1:  $\sigma_{rms} < 0.1$  nanometers

Specification	Test Method	Data Delivered
Physical Dimensions	Visual Inspection	Diameter, Thickness, Bevel dimension, parallelism
Side and Bevel Polish	Visual Inspection	Inspection Report included with Certification
Scratches and Point defects	Visual Inspection	Inspection Report included with Certification
Identification Serial number	Visual Inspection	Inspection Report included with Certification
Surface Errors - Surface Figure & Low Spatial Frequency	Interferometry	Surface Map
Surface Errors - High Spatial Frequency	Atomic Force Microscope	Numerical values included with Certification

## Table 1: Required Deliverable Data

Format: All Data shall be delivered according to Table 1.